TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π–MOSV)

2SK2401

Chopper Regulator, DC-DC Converter and Motor Drive Applications

 $\begin{array}{ll} \bullet & Low\ drain-source\ ON\ resistance & : R_{DS}\ (oN) = 0.13\ \Omega\ (typ.) \\ \bullet & High\ forward\ transfer\ admittance & : |Y_{fs}| = 17\ S\ (typ.) \\ \bullet & Low\ leakage\ current & : I_{DSS} = 100\ \mu A\ (max)\ (V_{DS} = 200\ V) \\ \bullet & Enhancement\ mode & : V_{th} = 1.5 {\sim} 3.5\ V\ (V_{DS} = 10\ V,\ I_D = 1\ mA) \\ \end{array}$

Absolute Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	200	V
Drain-gate voltage (R	_{GS} = 20 kΩ)	V_{DGR}	200	V
Gate-source voltage		V_{GSS}	±20	٧
Drain current	DC (Note 1)	I_{D}	15	Α
	Pulse (Note 1)	I_{DP}	45	Α
Drain power dissipatio	n (Tc = 25°C)	P_{D}	75	W
Single pulse avalanche energy (Note 2)		E _{AS}	166	mJ
Avalanche current		I _{AR}	15	Α
Repetitive avalanche energy (Note 3)		E _{AR}	7.5	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature range		T _{stg}	-55~150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.67	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

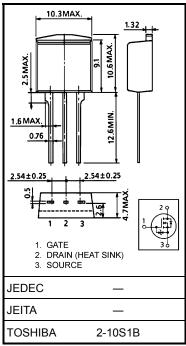
Note 2: V_{DD} = 50 V, T_{ch} = 25°C (initial), L = 1.2 mH, R_G = 25 Ω , I_{AR} = 15 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

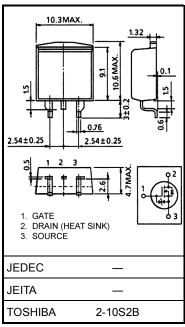
This transistor is an electrostatic-sensitive device.

Please handle with caution.

Unit: mm



Weight: 1.5 g (typ.)



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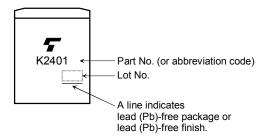
Electrical Characteristics (Ta = 25°C)

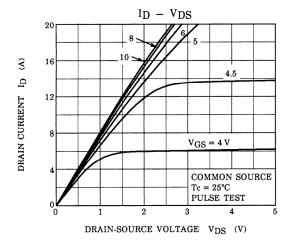
Charac	eteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 200 V, V _{GS} = 0 V		_	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	200	_	_	V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source Ol	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 10 A		0.13	0.18	Ω
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 10 A	10	17	_	S
Input capacitano	е	C _{iss}			2000	_	
Reverse transfer	r capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		200	-	pF
Output capacitance		C _{oss}]		600	_	
Switching time	Rise time	t _r	$V_{GS} \stackrel{10 \text{ V}}{\text{0 V}} \stackrel{\text{I}_{D} = 10 \text{ A}}{\text{V}_{out}} \\ \stackrel{\text{R}_{L}}{\text{V}_{DD} = 100 \text{ V}}$	_	35	_	
	Turn-on time	t _{on}		_	50	_	ns
	Fall time	t _f		l	10	l	113
	Turn-off time	t _{off}	Duty \leq 1%, $t_{\rm W} = 10~\mu \rm s$	_	66	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	40	_	
Gate-source charge		Q_{gs}	$V_{DD} \approx 100 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$		25	_	nC
Gate-drain ("miller") charge		Q_{gd}			15	_	

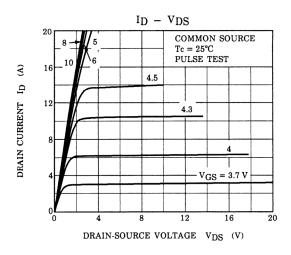
Source-Drain Ratings and Characteristics (Ta = 25°C)

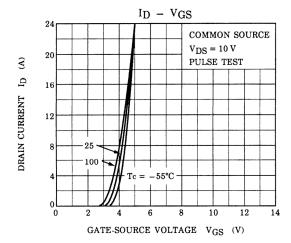
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	15	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	45	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 15 A, V _{GS} = 0 V	_	_	-2.0	V
Reverse recovery time		I _{DR} = 15 A, V _{GS} = 0 V		180		ns
Reverse recovery charge	Qrr	dl _{DR} / dt = 100 Å / μs	_	1.13	_	μC

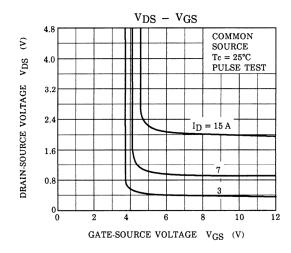
Marking

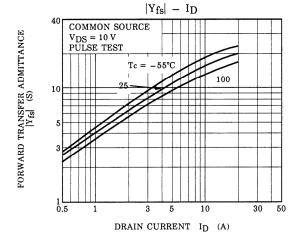


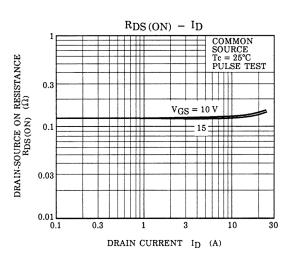


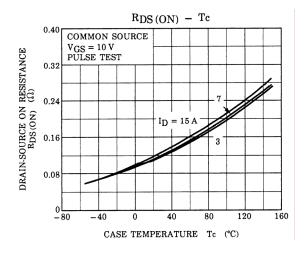


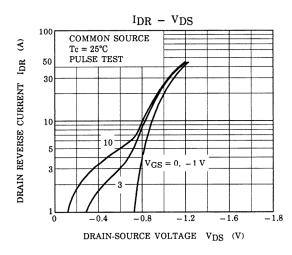


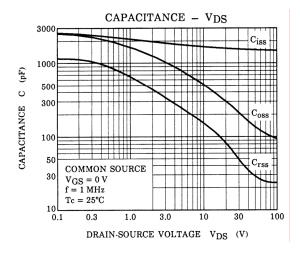


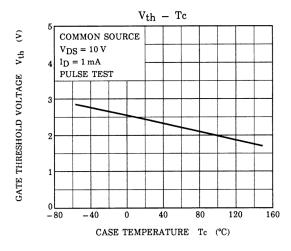


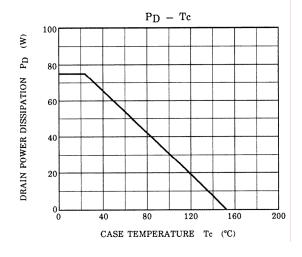


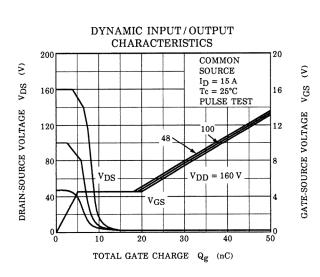




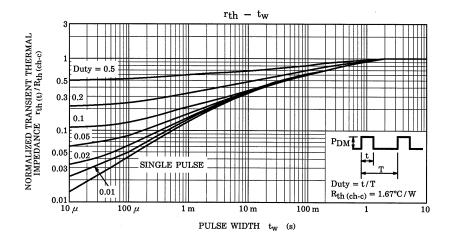


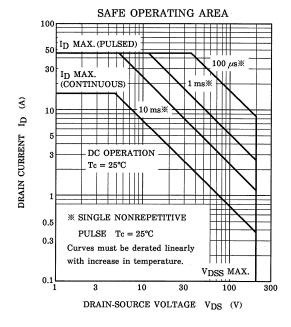


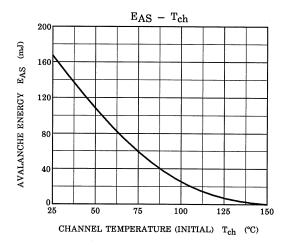


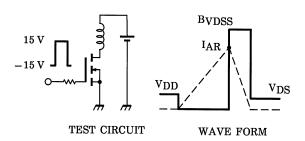


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$$\begin{aligned} &R_G = 25 \ \Omega \\ &V_{DD} = 50 \ V, \ L = 1.2 \ mH \end{aligned} \qquad EAS = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right)$$

5 2006-11-20

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